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Application/Control	No.

Applicant(s)/Patent	under
Reexamination	

10/069,176

Examiner

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SEARCHED			
Class	Subclass	Date	Examiner
713	189, 193	6/6/2007	YCS
380	277-278	6/6/2007	YĊS
380	44-45	6/6/2007	YCS
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